

Notice of References Cited	Application/Control No. 10/774,535		Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Leith A. Al-Nazer		Art Unit 2821	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,910,792	06-1999	Hansen et al.	345/74.1
*	B	US-6,388,649	05-2002	Tanaka et al.	345/89
*	C	US-5,889,503	03-1999	Kikuchi et al.	345/98
	D	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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